## **COURSE DESCRIPTION**

1. Program identification information

1.1 Higher education institution	University Politehnica of Bucharest
1.2 Faculty	Faculty of Electronics, Telecommunications and Information Technology
1.3 Department	Electronic Devices, Circuits and Architectures
1.4 Domain of studies	Electronic Engineering, Telecommunications and Informational Technologies
1.5 Cycle of studies	Licence (engineering)
1.6 Program of studies/Qualification	Tehnologii și Sisteme de Telecomunicații (în limba engleză)

### 2. Course identification information

2.1 Name o	f the	course	ulil fr	DIES A FINI	Electro	onic Devices	В	
2.2 Lecture	r			Work Light	Prof.di	ing. Gabriel	DIMA	
2.3 Instruct	or fo	r practical activi	ities	(C16) 10.	As.dr.i	ng. Laurentiu	TEODORES	CU
2.4 Year	II	2.5 Semester	3	2.6 Eva	luation	Final	2.7 Course	Mandatory
of studies	, 14 N		er i si	type		Examination	choice type	

3. Total estimated time (hours per semester for academic activities)

3.1 Number of hours per week, out of which	5	3.2 course	3	3.3 practical activities	2
3.4 Total hours in the curricula, out of which	70	3.5 course	42	3.6 practical activities	28
3.7 Distribution of time	in the	New Year			hours
Study according to the manual, course s	suppo	ort, bibliogra	ohy a	nd hand notes	25
Supplemental documentation (library, e	lectr	onic access r	esour	ces, in the field, etc)	3
Preparation for practical activities, hom					5
Tutoring					0
Examinations					3
Other activities			1.4		0
3.8 Total hours of individual study	JL 13		70		

3.8 Total hours of individual study	70
3.9 Total hours per semester	130
3.10 Number of ECTS credit points	5

4. Prerequisites (if applicable)

4.1 curricular	Electrotechnical Fundamentals, Physics
4.2 competence-	General principles of quantum physics, electricity, mathematics,
based	electric circuit analysis

5. Requisites (if applicable)

5.1 For running the	None	COST Dilector	anskard-údan a s
course			
5.2 For running of	None		(1/41 - J )
the applications			AND DESCRIPTION TO

6. Specific competences

6.1 Professional	C1. Using of fundamental elements that refer to the ele	ectronic
competences	devices, circuits and instrumentation	
6.2 Transversal Competences	Not applicable.	1.1

7. Course objectives (as implied by the grid of specific competences)

7.1 General objective of the course	The course introduces the students the physics, electrical behavior and operating modes of the most important solid state devices: diodes, MOSFETs, JFETs and bipolar transistors. In order to understand the physical operation of these devices, basic concepts regarding semiconductor physics, the p-n junction theory and the MOS capacitor are presented.
7.2 Specific objectives	<ul> <li>Modeling of the devices by analytical equations and small signal equivalent circuits;</li> <li>Simplified relations for model parameters suitable for hand calculations;</li> <li>High frequency operation and thermal issues of the devices;</li> <li>Several techniques for obtaining the dc operating point of the device</li> <li>Different biasing methods and a large variety of dc circuits;</li> <li>Analysis using static and small - signal for various diode circuits and configurations of single stage amplifiers with bipolar transistors, MOSFETs and JFETs.</li> </ul>

#### 8. Contents

8.1 Lectures	Teaching techniques	Remarks
1. Semiconductors Fundamentals	Teaching is based on Power point	Constant
1.1 Semiconductors. Insulators. Metals	slide-show lecture notes. Each	Marriso
<ul> <li>1.2 Electrons and holes</li> <li>1.3 Intrinsic and extrinsic semiconductors</li> <li>1.4 Drift and diffusion</li> <li>1.5 Generation and recombination</li> <li>1.6 Semiconductor equations</li> <li>1.7 Electrical signals for semiconductor devices</li> <li>1.7.1 Analog and digital signals</li> <li>1.7.2 Small signal and large signal</li> <li>1.7.3 Stationary and Quasi-Stationary Signals.  Operation at high frequencies. The effect of internal capacities</li> </ul>	slide is explained in detail by means of oral presentation. All course materials are available online on the course's website (Moodle – http://electronica.curs.pub.ro).	6 Hrs
<ul> <li>2. Semiconductor Diodes</li> <li>2.1 Diodes applications</li> <li>2.2 pn Junction</li> <li>2.2.1 Electrostatics of pn junction</li> <li>2.2.2 Current voltage relationships</li> <li>2.2.3 pn junction breakdown</li> <li>2.2.4 Small signal modeling</li> </ul>	Ciryaniana in anti-	9 Hrs
2.3 pn Junction diode		49 -
2.4 Metal-semiconductor contact	Andreadistrated 121 to 121	
2.5 Light-emitting diode (LED)	147 040	
2.6 Thermal behavior of semiconductor diodes	The Market of the Market	
2.7 Applications	7.02.12	ar than say

3. Junction field effect transistor(J-FET)	and a share of the second state of the second	
3.1 Field effect transistor concept.	area from the control of the control	
Classification		
3.2 J-FET structure. Operation mode	The state of the s	5 Hrs
3.3 Threshold voltage. Channel conductance		
3.4 Current voltage relationships		
3.5 J-FET modeling		
3.6 Temperature dependence		
3.7 Applications	e anno e la binaria es absolutablem e qui como el como	
4. Metal Oxide Semiconductor (MOS)		
Field Effect Transistor	kabadan Ambawi, piga mengahan di kabada sa Pala	
4.1 MOS capacitor		
4.2 Enhancement MOS.		
4.2.1 Structure. Channel inducing		
4.2.2 Threshold voltage. Channel		10 Hrs
conductance		
4.2.3 Operation modes	Stranger with an all the realist of	
4.2.4 Current voltage relationships.		
4.2.5 MOS transistor models		
4.3 Depletion MOS. Structure and operation	The state of the s	
4.4 Applications		N MA
5. Bipolar transistor	NITS for Course some products production of the	
2 10s		
5.1 Device structure. <i>npn</i> and <i>pnp</i> transistors		
5.2 Transistor effect	Antigon and the Tree of the Control	
5.3 Ebers-Moll equations		
5.4 Operating modes. Configurations	20 10 Company (1971)	
5.5 Simplified modeling		12 Hrs
5.6 Second order characteristics of transistor	THE PERSON A CORPORATION ASSESSMENT OF THE PROPERTY OF THE PERSON OF THE	12 1115
5.7 Full modeling in forward active mode	IN THE CLASSICAL PROPERTY OF SECTION OF SECT	
5.8 High frequency transistor response	loss affect and to be level	
5.9 Transistor breakdown voltages	integral of the state of the property	
5.10Transistor temperature behavior		
5.11 Comparison between bipolar junctions		
transistor and MOS transistor	A STANDARD SO	

#### References

- 1) G. Dima, *Electronic Devices* lecture notes (electronic), 2011.
- 2) R. Muller, T. Kamins, *Devices Electronics for Integrated Circuits*, Wiley and Sons, New York, 1988.
- 3) R. F. Pierret, G. W. Neudeck, *Modular Series on Solid State Devices*, Addison Wesley, New York, 1990
- 4) P. R. Gray, P. J. Hurst, S. H. Lewis, R. G. Meyer, Analysis and Design of Analog IC's, ediția 4, J. Whiley & Sons, 2001.
- 5) B. Razavi, Design of Analog CMOS Integrated Circuits, McGrawHill, 2001.
- 6) A. Sedra, K.C. Smith, *Microelectronic Circuits*, ediția a 5-a, Oxford University Press, 2004.
- 7) Course entry on the Moodle eLearning platform: http://electronica.curs.pub.ro

8.3 Seminars	Teaching techniques	Remarks
Seminar1 - Electrons and holes. Extrinsic semiconductors. Semiconductor resistivity	Oral exposition. The teaching method used is problem-solving. Direct involvement of students in this process	2 Hrs
Seminar 2 – PN junction. Depletion region.	is stimulated. The main seminar materials are: lecture	2 Hrs

Seminar 3 – PN junction. Current-voltage relationships.	notes and the "Dispozitive şî circuite electronice-Probleme" şi "Dispozitive	2 Hrs
Seminar 4 - Semiconductor	electronice-Probleme" exercises books.	0.11
diodes. Diode dc operating point.		2 Hrs
Seminar 5 - Diode circuits. DC	assent the coloniar to asset	O III
and Small signal analysis	digentary.	2 Hrs
Seminar 6 - JFET. JFET current		2 Hrs
sources.		2 HIS
Seminar 7 - JFET amplifier	(194) remakacalese	2 Hrs
stages. Common source.	14.5 J.O. Holistophy (14.1)	21118
Seminar 8 - MOS transistor. MOS	3010	2 Hrs
current sources.	at Mos	21118
Seminar 9 - JFET and MOS	uto Channel Indexis	
amplifier stages. Common gate	old voltage. Charmer	2 11
and common drain.	The second secon	where
Seminar 10 - JFET and MOS	comment to the second to the s	
amplifier stages. Common source	I volume the extress	2 Hrs
stage with source degeneration.	at stranger	Chrysler C.
Seminar 11 - Bipolar transistor.	PODS Street on and opposition	
Device DC operating point. Bias		2 Hrs
circuits.	(0.04)0	total and the beautiful to
Seminar 12 – Bipolar transistor		2 Hrs
current sources.	eture, and and only branescore	are national t
Seminar 13 - Bipolar transistor	effect.	
amplifier stages. Common emitter	septions (	2 Hrs
and emitter degeneration.	ander Confirmation	A Charleston
Seminar 14 - Bipolar transistor	modoling	S S to three
amplifier stages. Common base	ter characteristics of transferor	2 Hrs
and common collector.	Una la flavores service es una	Shoot Bull 5

#### References

- 1) G. Brezeanu, G. Dilimot, F. Mitu, F. Drăghici, *Dispozitive electronice-Probleme*, Ed. Rosetti Educațional, București, 2009.
- 2) P. R. Gray, P. J. Hurst, S.H.Lewis, R.G.Meyer, *Analysis and Design of Analog IC's*, ediția 4, Whiley & Sons, 2001.
- 3) D. Dascălu et all, *Dispozitive și Circuite Electronice Probleme*, Ed. Didactica și Pedagogică, 1982.
- 4) Course entry on the Moodle eLearning platform: http://electronica.curs.pub.ro.

# 9. Bridging the course content with the expectations of the epistemic community representatives, professional associations and employers representatives for the domain of the program

Electronic Devices represents a fundamental topic for an electrics and electronics engineering specialist. Thorough knowledge of physics and semiconductor electronics devices have made possible major progress, explaining the unparalleled achievements in mobile communications, computers or audio and video electronic systems.

This course illustrates, by comments and numerical data, the electrical behavior, models and equivalent circuits of diodes, field effect and bipolar transistors, as well as their uses inside a circuit. Special emphasis is made on amplifier stages.

By professional selection of important knowledge, of immediate or timeless topicality, the students are offered complete scientific and technical training, allowing employment opportunities after graduation in any electronics, telecommunications or information technology company. Thus, the policy of "Politehnica" University of Bucharest, of promoting subjects strongly correlated with the requirements of present top industry such as electronics, is followed.

#### 10. Evaluation

Type of activity	10.1 Evaluation criteria	10.2 Evaluation methods	10.3 Weight in the final mark
10.4 Lectures	<ol> <li>Knowledge of fundamental theoretical concepts;</li> <li>Knowledge of using theory to solve specific problems;</li> <li>Understanding and use of model parameters and equivalent circuits</li> </ol>	A written midterm test, which covers 50% of the lecture, focusing both on theoretical knowledge evaluation and solving problems that illustrate semiconductors use in devices fabrication and the operation of <i>pn</i> junction and diodes in specific electronic circuits.	40%
	for diodes, field effect and bipolar transistors.	Final examination, with the possibility of retaking the midterm test. This exam is focused both on theoretical knowledge evaluation and solving problems that illustrate operation and parameters of field effect and bipolar transistors, in specific single transistor amplifiers.	40%
10.5 Seminars	Understanding and use of established models for diodes, field effect and bipolar transistors in specific circuits.		20%

10.6 Minimal performance standard

• Acquiring a minimum score of 50% of the points allocated for the activities seminar/course.

 Acquiring a minimum score of 50% for the midterm test and a minimum of 50% for the final examination.

Date,

Lecturer,

Instructor for practical activities,

11.09.2017

Prof.dr.ing Gabriel DIMA

As.dr.ing. Laurentiu TEODORESCU

Date of department approval,

18.09.2017

Head of Department,

Prof.dr.ing Claudius DAN